

**Search Notes**

Application/Control No.

10/562,871

Examiner

Huyen Le

Applicant(s)/Patent under  
Reexamination

GRUBER ET AL.

Art Unit

3751

**SEARCHED**

Class	Subclass	Date	Examiner
401	270 271 272 275 280 292	9/10/2009	HL
	263 132		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
US-PBPUB		1/4/2010	HL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR